

8-Channel, Dual 4-Channel, Triple 2-Channel (Triple SPDT) Multiplexers

DESCRIPTION

The DG4051A, DG4052A and DG4053A are high precision CMOS analog multiplexers. The DG4051A is an 8-channel multiplexer, the DG4052A is a dual 4-channel multiplexer and the DG4053A is a triple 2-channel multiplexer or triple SPDT.

Designed to operate from a + 2.7 V to + 12 V single supply or from a ± 2.5 V to ± 5 V dual supplies, the DG4051A, DG4052A and DG4053A are fully specified at + 3 V, + 5 V and ± 5 V. All control logic inputs have guaranteed 2.0 V logic high limit when operating from + 5 V or ± 5 V supplies and 1.4 V when operating from a + 3 V supply.

Channel leakage is typically in the range of 10 pA, and switch charge injection is less than 0.5 pC. Coupled with very low switch capacitance, these devices are ideal for high precision signal switching and multiplexing.

All switches conduct equally well in both directions, offering rail to rail analog signal switching and can be used both as multiplexers as well as de-multiplexers.

The DG4051A, DG4052A and DG4053A operating temperature is specified from - 40 °C to + 125 °C and are available in 16 pin TSSOP and the ultra compact 1.8 mm x 2.6 mm miniQFN16 packages.

FEATURES

- + 2.7 V to + 12 V single supply operation
- ± 2.5 V to ± 5 V dual supply operation
- Fully specified at + 3 V, + 5 V, ± 5 V
- 100 Ω maximum on-resistance
- Low voltage, 2.5 V CMOS/TTL compatible
- Low charge injection (< 0.5 pC typ.)
- High - 3 dB bandwidth: 330 MHz to 700 MHz
- Low switch capacitance ($C_{S(off)}$ 3 pF typ.)
- Excellent isolation and crosstalk performance (typ. 47 dB at 100 MHz)
- 16 pin SOIC, TSSOP and miniQFN package (1.8 mm x 2.6 mm)
- Fully specified from - 40 °C to + 85 °C and - 40 °C to + 125 °C
- Compliant to RoHS directive 2002/95/EC

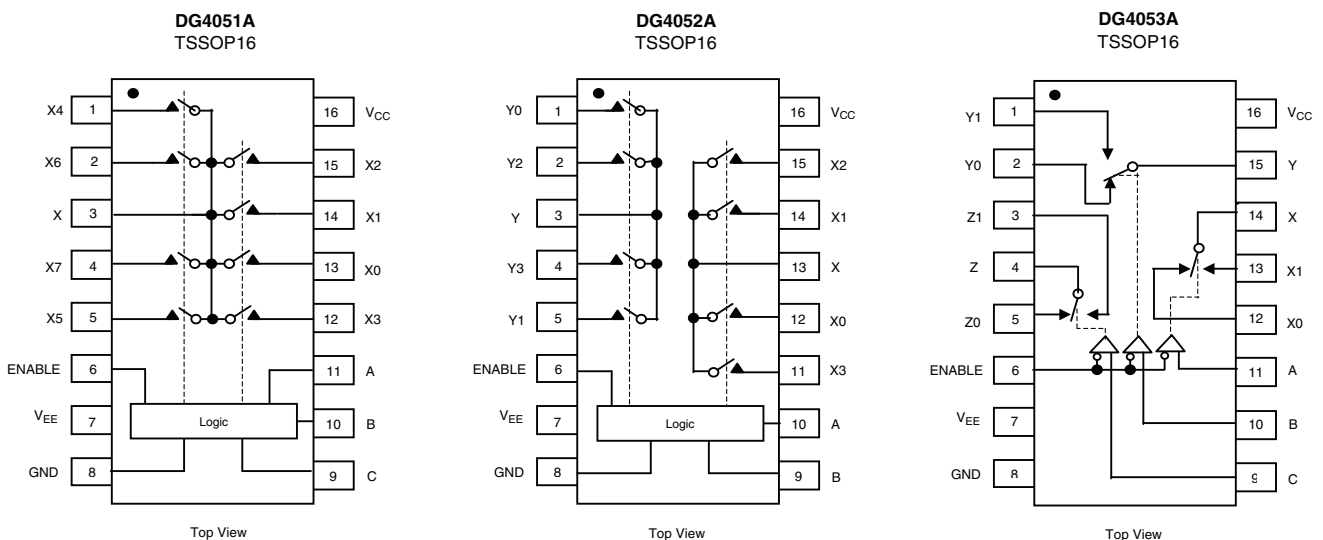


RoHS
COMPLIANT

APPLICATIONS

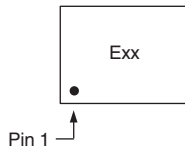
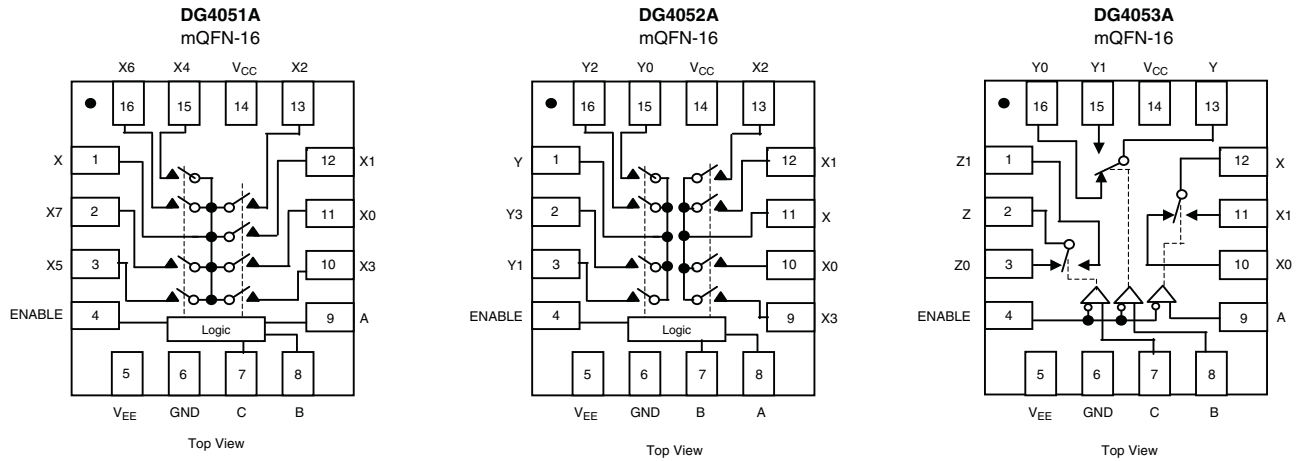
- Instruments
- Healthcare and medical equipments
- Touch panel
- Automated test equipment
- Automation and control
- High precision data acquisition
- Communication system

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



ENABLE = LO, all switches are controlled by addr pins.
ENABLE = HI, all switches are off.

FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



Device Marking: Exx for DG4051A (miniQFN16) Fxx for DG4052A Gxx for DG4053A
xx = Date/Lot Traceability Code

TRUTH TABLE						
Enable Input	Select Inputs			On Switches		
	C	B	A	DG4051A	DG4052A	DG4053A
H	X	X	X	All Switches Open	All Switches Open	All Switches Open
L	L	L	L	X to X0	X to X0, Y to Y0	X to X0, Y to Y0, Z to Z0
L	L	L	H	X to X1	X to X1, Y to Y1	X to X1, Y to Y0, Z to Z0
L	L	H	L	X to X2	X to X2, Y to Y2	X to X0, Y to Y1, Z to Z0
L	L	H	H	X to X3	X to X3, Y to Y3	X to X1, Y to Y1, Z to Z0
L	H	L	L	X to X4	X to X0, Y to Y0	X to X0, Y to Y0, Z to Z1
L	H	L	H	X to X5	X to X1, Y to Y1	X to X1, Y to Y0, Z to Z1
L	H	H	L	X to X6	X to X2, Y to Y2	X to X0, Y to Y1, Z to Z1
L	H	H	H	X to X7	X to X3, Y to Y3	X to X1, Y to Y1, Z to Z1

ORDERING INFORMATION		
Temp Range	Package	Part Number
DG4051A, DG4052A, DG4053A		
- 40 °C to 125 °C ^a	16-Pin TSSOP	DG4051AEQ-T1-E3 DG4052AEQ-T1-E3 DG4053AEQ-T1-E3
	16-Pin miniQFN	DG4051AEN-T1-E4 DG4052AEN-T1-E4 DG4053AEN-T1-E4

Notes:
a. - 40 °C to 85 °C datasheet limits apply.



ABSOLUTE MAXIMUM RATINGS $T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted			
Parameter	Limit	Unit	
V+ to V-	14	V	
GND to V-	7		
Digital Inputs ^a , V_S , V_D	(V-) - 0.3 to (V+) + 0.3 or 30 mA, whichever occurs first		
Continuous Current (Any terminal)	30	mA	
Peak Current, S or D (Pulsed 1 ms, 10 % duty cycle)	100		
Storage Temperature	- 65 to 150	$^\circ\text{C}$	
Power Dissipation ^b	16-Pin TSSOP ^c	450	mW
	16-Pin miniQFN ^{d, e}	525	
Thermal Resistance ^b	16-Pin TSSOP	178	$^\circ\text{C/W}$
	16-Pin miniQFN ^e	152	

Notes:

- a. Signals on SX, DX, or INX exceeding V+ or V- will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
- b. All leads welded or soldered to PC board.
- c. Derate 5.6 mW/ $^\circ\text{C}$ above 70 $^\circ\text{C}$.
- d. Derate 6.6 mW/ $^\circ\text{C}$ above 70 $^\circ\text{C}$.
- e. Manual soldering with iron is not recommended for leadless components. The miniQFN-16 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper lip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

SPECIFICATIONS FOR DUAL SUPPLIES									
Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_{CC} = +5\text{ V}$, $V_{EE} = -5\text{ V}$ $V_{IN(A, B, C \text{ and } ENABLE)} = 2.0\text{ V}$, 0.8 V^a	Temp. ^b	Typ. ^c	- 40 $^\circ\text{C}$ to 125 $^\circ\text{C}$		- 40 $^\circ\text{C}$ to 85 $^\circ\text{C}$		Unit
					Min. ^d	Max. ^d	Min. ^d	Max. ^d	
Analog Switch									
Analog Signal Range ^e	V_{ANALOG}		Full		- 5	5	- 5	5	V
On-Resistance	R_{ON}	$I_S = 1\text{ mA}$, $V_D = -3\text{ V}$, 0 V , $+3\text{ V}$	Room Full	66		100 125		100 118	Ω
On-Resistance Match	ΔR_{ON}	$I_S = 1\text{ mA}$, $V_D = \pm 3\text{ V}$	Room Full	3		6 10		6 8	
On-Resistance Flatness	$R_{FLATNESS}$	$I_S = 1\text{ mA}$, $V_D = -3\text{ V}$, 0 V , $+3\text{ V}$	Room Full	12		16 20		16 18	
Switch Off Leakage Current	$I_{S(off)}$	$V_+ = 5.5\text{ V}$, $V_- = -5.5\text{ V}$, $V_D = \pm 4.5\text{ V}$, $V_S = \mp 4.5\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	nA
	$I_{D(off)}$		Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	
Channel On Leakage Current	$I_{D(on)}$	$V_+ = 5.5\text{ V}$, $V_- = -5.5\text{ V}$, $V_S = V_D = \pm 4.5\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	
Digital Control									
Input Current, V_{IN} Low	I_{IL}	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 0.8 V	Full	0.01	- 1	1	- 1	1	μA
Input Current, V_{IN} High	I_{IH}	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 2.0 V	Full	0.01	- 1	1	- 1	1	
Input Capacitance ^e	C_{IN}	$f = 1\text{ MHz}$	Room	3.4					pF
Dynamic Characteristics									
Off Isolation	OIRR	$R_L = 50\ \Omega$, $C_L = 1\text{ pF}$	f = 10 MHz	Room	67				dB
			f = 100 MHz	Room	46				
Channel-to-Channel Crosstalk	X_{TALK}		f = 10 MHz	Room	67				
			f = 100 MHz	Room	47				
Bandwidth, 3 dB	BW	$R_L = 50\ \Omega$	DG4051A	Room	330				MHz
			DG4052A	Room	450				
			DG4053A	Room	730				

SPECIFICATIONS FOR DUAL SUPPLIES									
Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_{CC} = +5\text{ V}$, $V_{EE} = -5\text{ V}$ $V_{IN(A, B, C \text{ and } ENABLE)} = 2.0\text{ V}$, 0.8 V^a	Temp. ^b	Typ. ^c	- 40 °C to 125 °C		- 40 °C to 85 °C		Unit
					Min. ^d	Max. ^d	Min. ^d	Max. ^d	
Dynamic Characteristics									
Transition Time	t_{TRANS}	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ see figure 1, 2, 3	Room Full	36		110 127		110 117	ns
Enable Turn-On Time	t_{ON}		Room Full	31		108 119		108 114	
Enable Turn-Off Time	t_{OFF}		Room Full	29		92 103		92 98	
Break-Before-Make Time Delay	t_D		Room Full		1		1		
Charge Injection ^e	Q	$V_g = 0\text{ V}$, $R_g = 0\ \Omega$, $C_L = 1\text{ nF}$	Room	0.25					pC
Off Isolation ^e	OIRR	$R_L = 50\ \Omega$, $C_L = 1\text{ pF}$ $f = 100\text{ kHz}$	Room	< - 90					dB
Channel-to-Channel Crosstalk ^e	X_{TALK}		Room	< - 90					
Source Off Capacitance ^e	$C_{S(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	3				pF
			DG4052A	Room	3				
			DG4053A	Room	3				
Drain Off Capacitance ^e	$C_{D(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	12				
			DG4052A	Room	7				
			DG4053A	Room	4				
Channel On Capacitance ^e	$C_{D(on)}$	$f = 1\text{ MHz}$	DG4051A	Room	17				
			DG4052A	Room	13				
			DG4053A	Room	11				
Total Harmonic Distortion ^e	THD	Signal = 5 V_{RMS} , 20 Hz to 20 kHz, $R_L = 600\ \Omega$	Room	0.28					%
Power Supplies									
Power Supply Current	I+	$V_{CC} = +5\text{ V}$, $V_{EE} = -5\text{ V}$ $V_{IN(A, B, C \text{ and } ENABLE)} = 0\text{ or }5\text{ V}$	Room Full	0.05		1 10		1 10	μA
Negative Supply Current	I-		Room Full	- 0.05	- 1 - 10		- 1 - 10		
Ground Current	I_{GND}		Room Full	- 0.05	- 1 - 10		- 1 - 10		



SPECIFICATIONS FOR UNIPOLAR SUPPLIES									
Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_{CC} = +5\text{ V}$, $V_{EE} = 0\text{ V}$ $V_{IN(A, B, C \text{ and } ENABLE)} = 2.0\text{ V}$, 0.8 V^a	Temp. ^b	Typ. ^c	- 40 °C to 125 °C		- 40 °C to 85 °C		Unit
					Min. ^d	Max. ^d	Min. ^d	Max. ^d	
Analog Switch									
Analog Signal Range ^e	V_{ANALOG}		Full		0	5	0	5	V
On-Resistance	R_{ON}	$I_S = 1\text{ mA}$, $V_D = 0\text{ V}$, $+3.5\text{ V}$	Room Full	107		165 205		165 194	Ω
On-Resistance Match	ΔR_{ON}	$I_S = 1\text{ mA}$, $V_D = +3.5\text{ V}$	Room Full	3.2		8 13		8 11	
On-Resistance Flatness	$R_{FLATNESS}$	$I_S = 1\text{ mA}$, $V_D = 0\text{ V}$, $+3\text{ V}$	Room Full	19		26 30		26 28	
Switch Off Leakage Current	$I_{S(off)}$	$V_+ = +5.5\text{ V}$, $V_- = 0\text{ V}$ $V_D = 1\text{ V}/4.5\text{ V}$, $V_S = 4.5\text{ V}/1\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	nA
	$I_{D(off)}$		Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	
Channel On Leakage Current	$I_{D(on)}$	$V_+ = +5.5\text{ V}$, $V_- = 0\text{ V}$ $V_D = V_S = 1\text{ V}/4.5\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	
Digital Control									
Input Current, V_{IN} Low	I_L	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 0.8 V	Full	0.01	- 1	1	- 1	1	μA
Input Current, V_{IN} High	I_H	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 2.0 V	Full	0.01	- 1	1	- 1	1	
Dynamic Characteristics									
Transition Time	t_{TRANS}	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ See Figure 1, 2, 3	Room Full	38		121 143		121 134	ns
Enable Turn-On Time	t_{ON}		Room Full	38		110 126		110 119	
Enable Turn-Off Time	t_{OFF}		Room Full	38		103 118		103 111	
Break-Before-Make Time Delay	t_D		Room Full		1		1		
Charge Injection ^e	Q	$V_g = 0\text{ V}$, $R_g = 0\ \Omega$, $C_L = 1\text{ nF}$	Full	0.5					pC
Off Isolation ^e	OIRR	$R_L = 50\ \Omega$, $C_L = 1\text{ pF}$ $f = 100\text{ kHz}$	Room	< - 90					dB
Channel-to-Channel Crosstalk ^e	X_{TALK}		Room	< - 90					
Source Off Capacitance ^e	$C_{S(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	3				pF
			DG4052A	Room	3				
			DG4053A	Room	4				
Drain Off Capacitance ^e	$C_{D(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	13				
			DG4052A	Room	8				
			DG4053A	Room	5				
Channel On Capacitance ^e	$C_{D(on)}$	$f = 1\text{ MHz}$	DG4051A	Room	18				
			DG4052A	Room	14				
			DG4053A	Room	11				
Power Supplies									
Power Supply Current	I_+	$V_{IN(A, B, C \text{ and } ENABLE)} = 0\text{ V}$ or 5 V	Room Full	0.05		1 10		1 10	μA
Negative Supply Current	I_-		Room Full	- 0.05	- 1 - 10		- 1 - 10		
Ground Current	I_{GND}		Room Full	- 0.05	- 1 - 10		- 1 - 10		

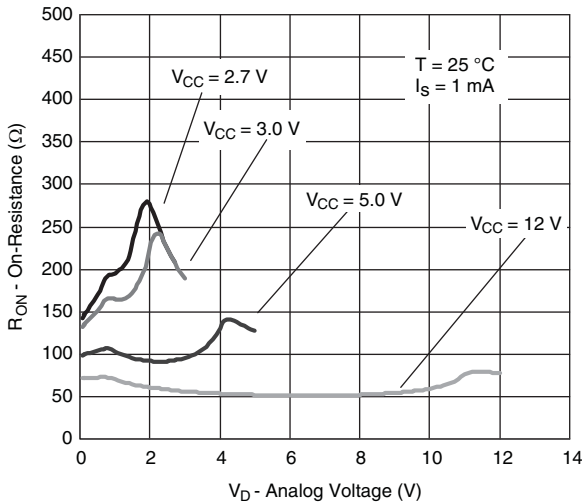
SPECIFICATIONS FOR UNIPOLAR SUPPLIES										
Parameter	Symbol	Test Conditions Unless Otherwise Specified $V_{CC} = +3\text{ V}$, $V_{EE} = 0\text{ V}$ $V_{IN(A, B, C \text{ and } ENABLE)} = 1.4\text{ V}$, 0.6 V^a		Temp. ^b	Typ. ^c	- 40 °C to 125 °C		- 40 °C to 85 °C		Unit
						Min. ^d	Max. ^d	Min. ^d	Max. ^d	
Analog Switch										
Analog Signal Range ^e	V_{ANALOG}		Full		0	3	0	3	V	
On-Resistance	R_{ON}	$I_S = 1\text{ mA}$, $V_D = 1.5\text{ V}$	Room Full	175		265 310		265 298	Ω	
Switch Off Leakage Current	$I_{S(off)}$	$V_+ = +3.3\text{ V}$, $V_- = 0\text{ V}$ $V_D = 0.3\text{ V}/3.0\text{ V}$, $V_S = 3.0\text{ V}/0.3\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5	nA	
	$I_{D(off)}$		Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5		
Channel On Leakage Current	$I_{D(on)}$	$V_+ = +3.3\text{ V}$, $V_- = 0\text{ V}$ $V_D = V_S = 0.3\text{ V}/3.0\text{ V}$	Room Full	± 0.02	- 1 - 50	1 50	- 1 - 5	1 5		
Digital Control										
Input Current, V_{IN} Low	I_L	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 0.6 V	Full	0.01	- 1	1	- 1	1	μA	
Input Current, V_{IN} High	I_H	$V_{IN(A, B, C \text{ and } ENABLE)}$ under test = 1.4 V	Full	0.01	- 1	1	- 1	1		
Dynamic Characteristics										
Transition Time	t_{TRANS}	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$ see figure 1, 2, 3	Room Full	81		172 218		172 194	ns	
Enable Turn-On Time	t_{ON}		Room Full	71		151 183		151 167		
Enable Turn-Off Time	t_{OFF}		Room Full	69		138 161		138 151		
Break-Before-Make Time Delay	t_D		Room Full		1		1			
Charge Injection ^e	Q	$V_g = 0\text{ V}$, $R_g = 0\ \Omega$, $C_L = 1\text{ nF}$	Room	0.5					pC	
Off Isolation ^e	OIRR	$R_L = 50\ \Omega$, $C_L = 1\text{ pF}$ $f = 100\text{ kHz}$	Room	< - 90					dB	
Channel-to-Channel Crosstalk ^e	X_{TALK}		Room	< - 90						
Source Off Capacitance ^e	$C_{S(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	4				pF	
			DG4052A	Room	3					
			DG4053A	Room	4					
Drain Off Capacitance ^e	$C_{D(off)}$	$f = 1\text{ MHz}$	DG4051A	Room	14					
			DG4052A	Room	8					
			DG4053A	Room	5					
Channel On Capacitance ^e	$C_{D(on)}$	$f = 1\text{ MHz}$	DG4051A	Room	19					
			DG4052A	Room	14					
			DG4053A	Room	11					
Power Supplies										
Power Supply Current	I+	$V_{IN(A, B, C \text{ and } ENABLE)} = 0\text{ V}$ or 3 V	Room Full	0.05		1 10		1 10	μA	
Negative Supply Current	I-		Room Full	- 0.05	- 1 - 10		- 1 - 10			
Ground Current	I_{GND}		Room Full	- 0.05	- 1 - 10		- 1 - 10			

Notes:

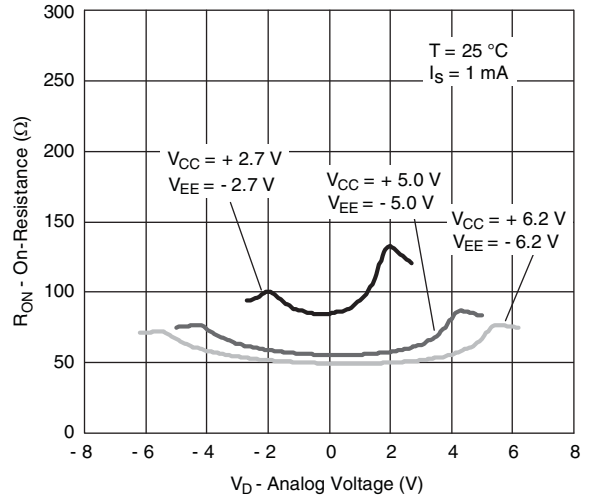
- a. V_{IN} = input voltage to perform proper function.
- b. Room = 25 °C, Full = as determined by the operating temperature suffix.
- c. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- d. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- e. Guaranteed by design, not subject to production test.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

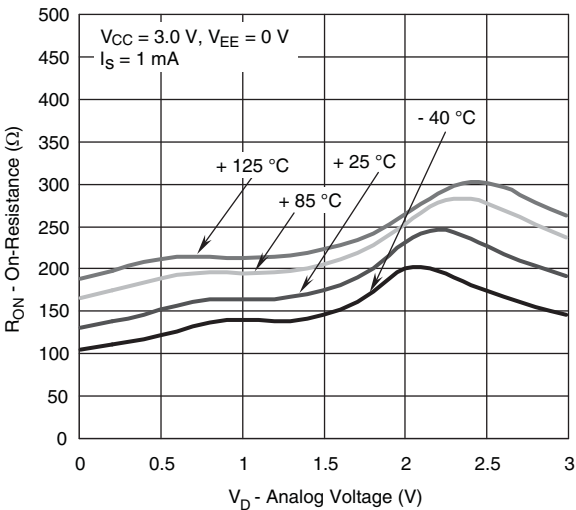
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



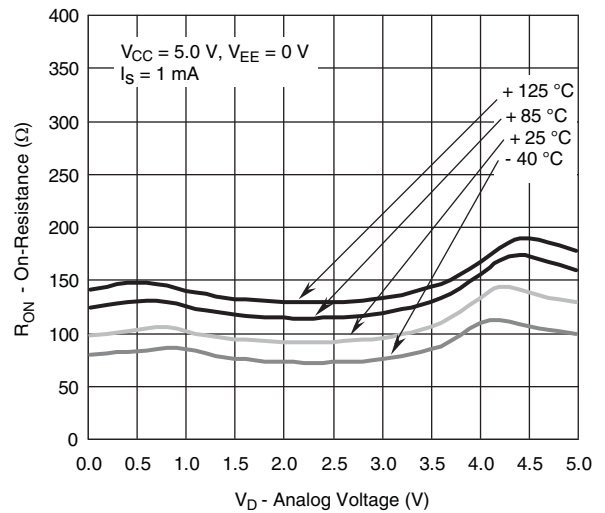
On-Resistance vs. V_D and Single Supply Voltage



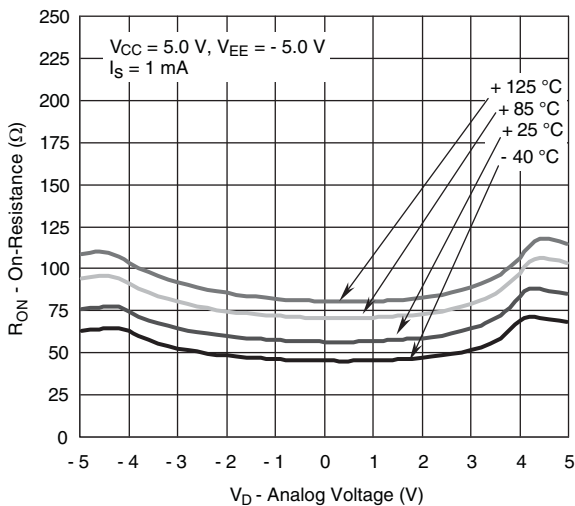
On-Resistance vs. V_D and Dual Supply Voltage



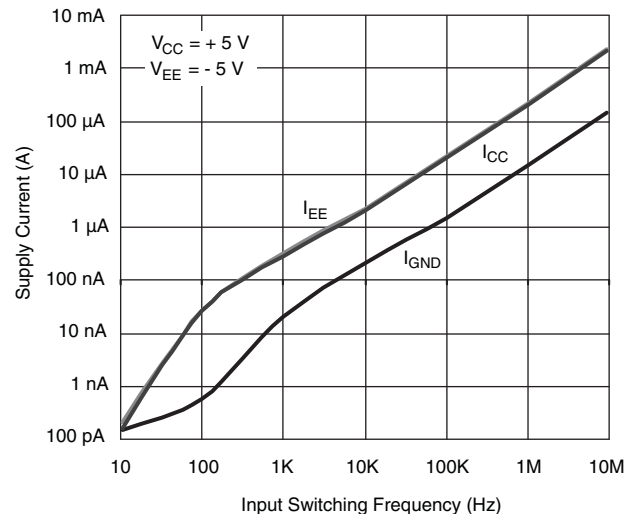
On-Resistance vs. Analog Voltage and Temperature at $V_{CC} = +3\text{ V}$, $V_{EE} = 0\text{ V}$



On-Resistance vs. Analog Voltage and Temperature at $V_{CC} = +5\text{ V}$, $V_{EE} = 0\text{ V}$

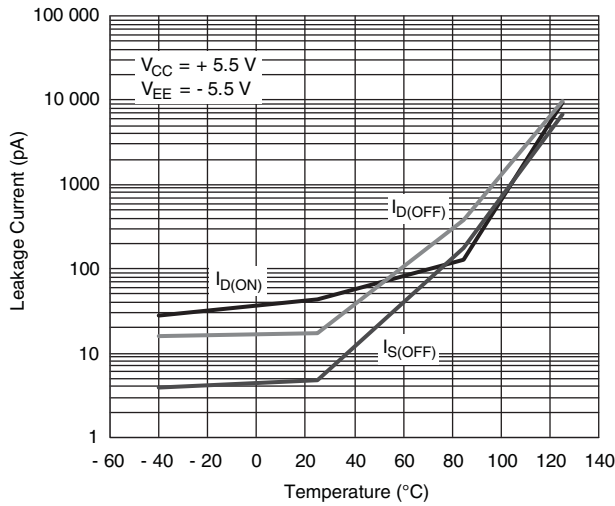


On-Resistance vs. Analog Voltage and Temperature at $V_{CC} = +5\text{ V}$, $V_{EE} = -5\text{ V}$

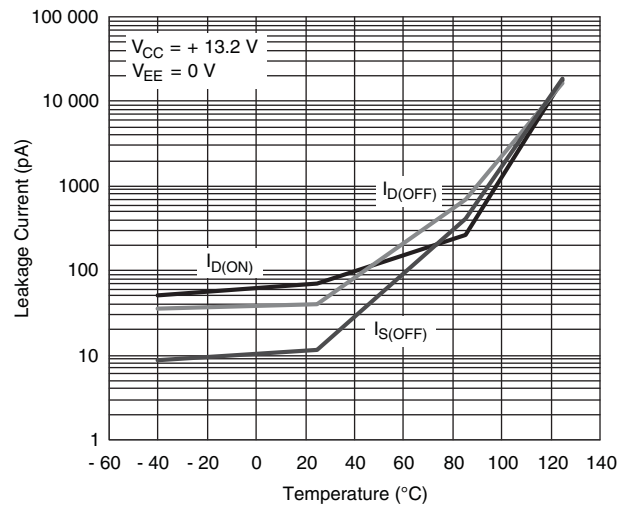


Supply Current vs. Input Switching Frequency

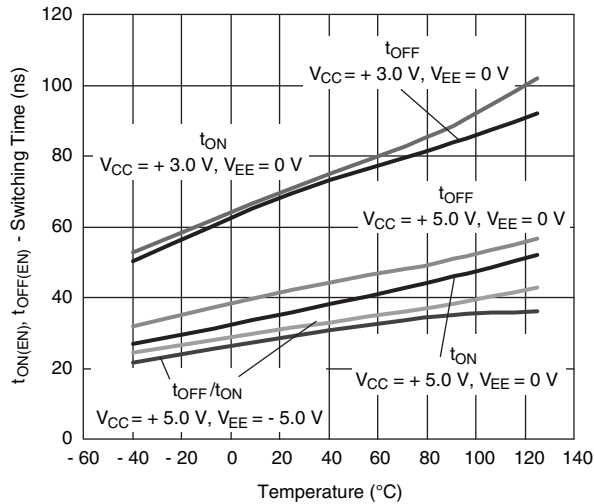
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



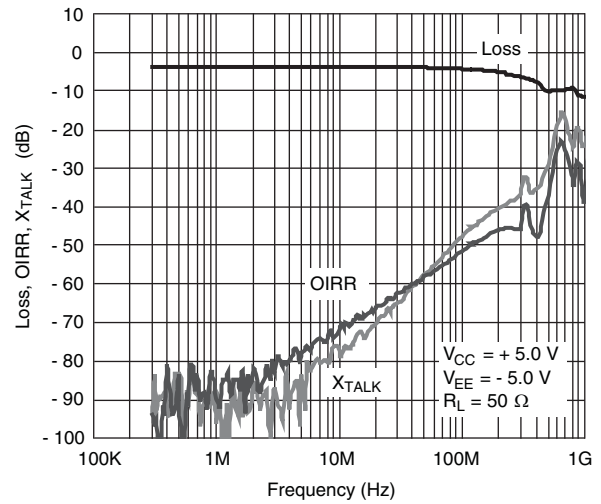
Leakage Current vs. Temperature



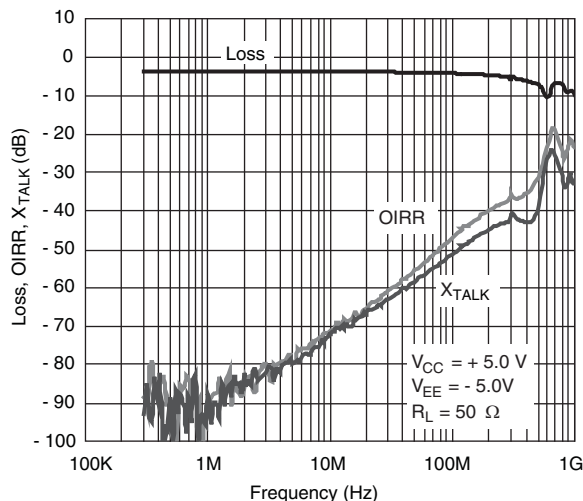
Leakage Current vs. Temperature



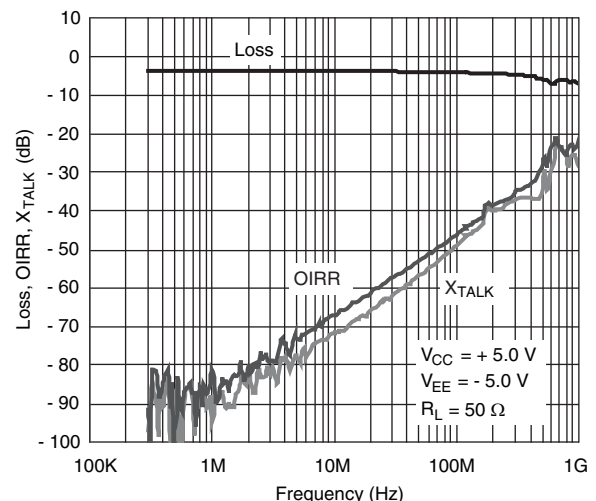
Switching Time vs. Temperature



DG4051A Insertion Loss, Off-Isolation, Crosstalk vs. Frequency at ± 5 V Supply

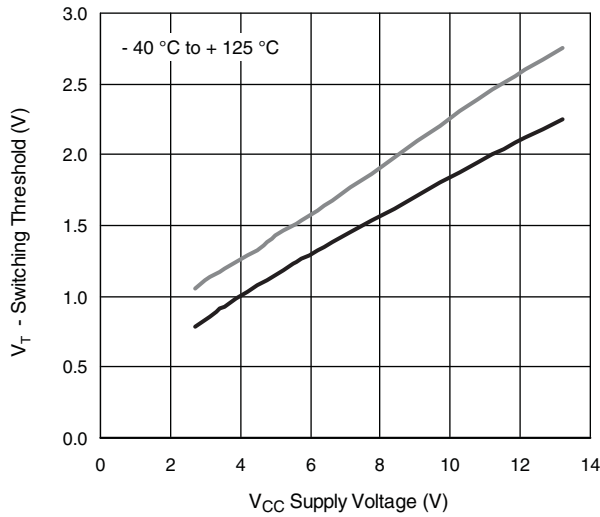


DG4052A Insertion Loss, Off-Isolation, Crosstalk vs. Frequency at ± 5 V Supply

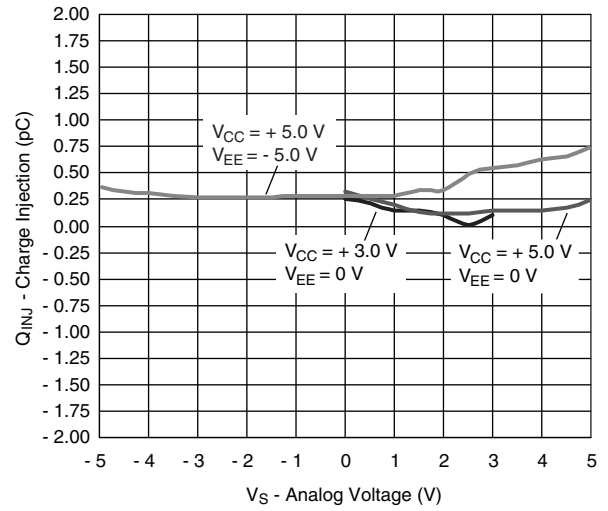


DG4053A Insertion Loss, Off-Isolation, Crosstalk vs. Frequency at ± 5 V Supply

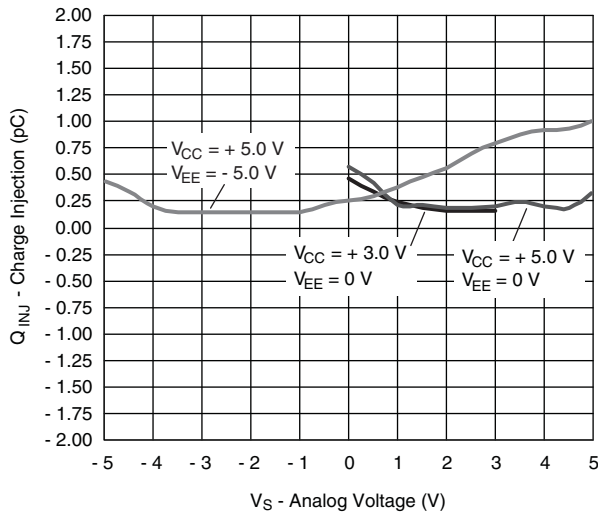
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



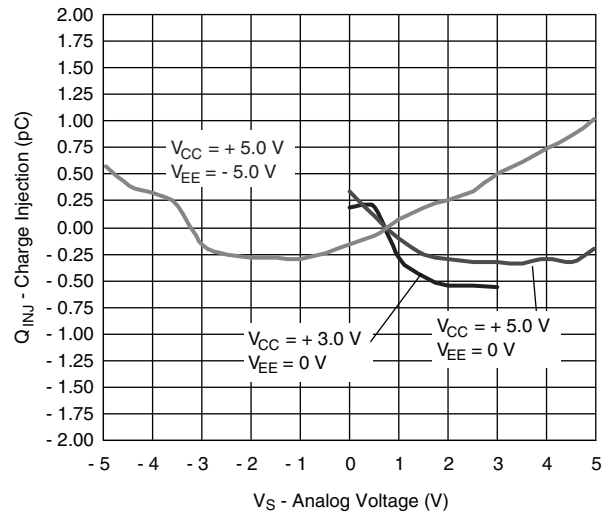
Switching Threshold vs. V_{CC} Supply Voltage



DG4051A Charge Injection vs. Analog Voltage



DG4052A Charge Injection vs. Analog Voltage



DG4053A Charge Injection vs. Analog Voltage

TEST CIRCUITS

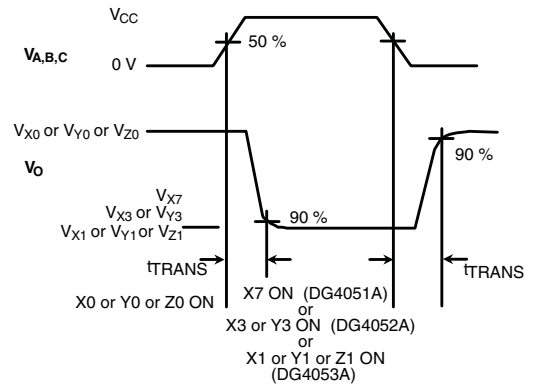
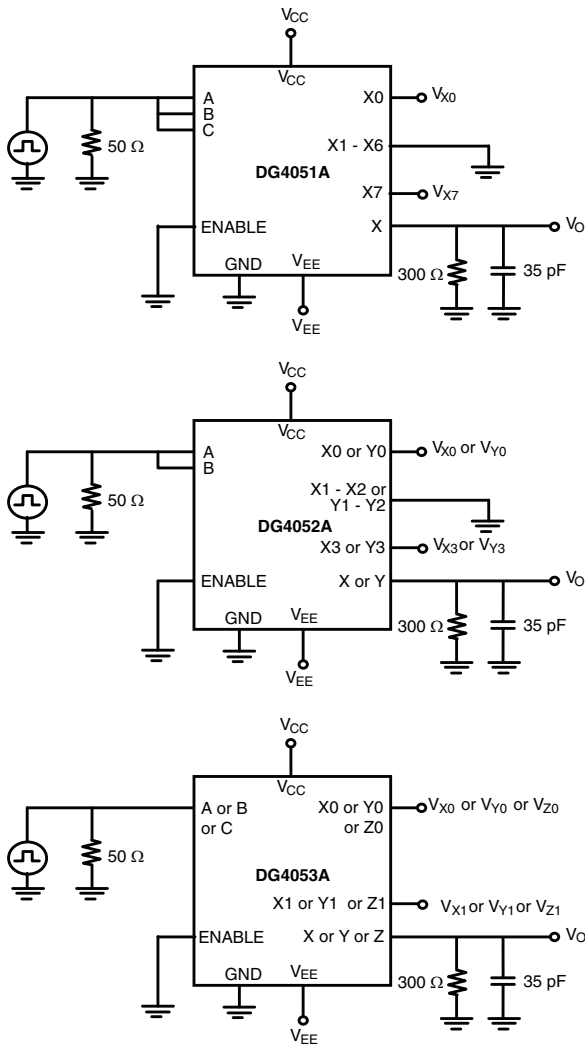


Figure 1. Transition Time

TEST CIRCUITS

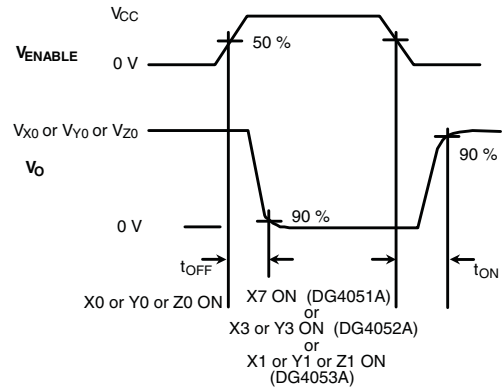
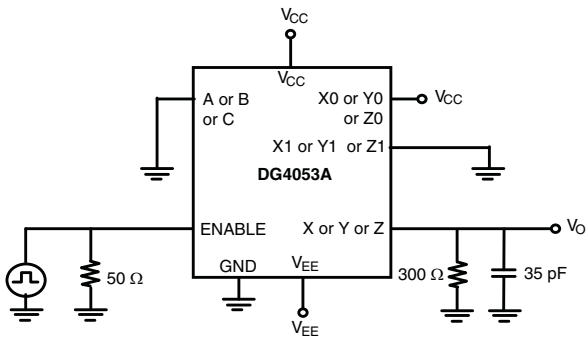
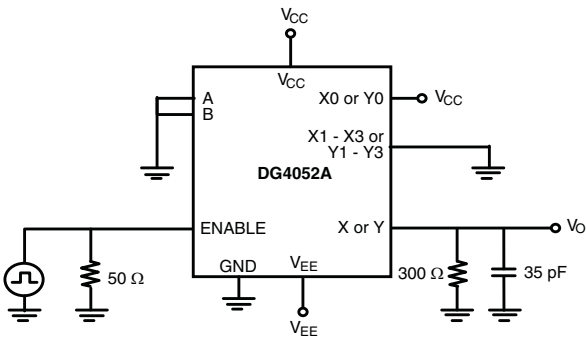
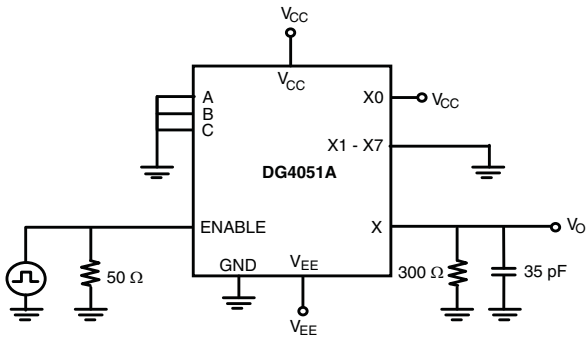


Figure 2. Enable Switching Time

TEST CIRCUITS

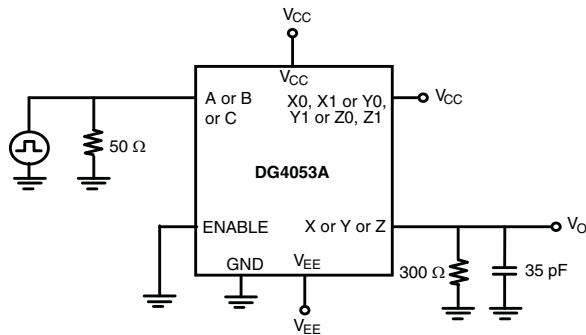
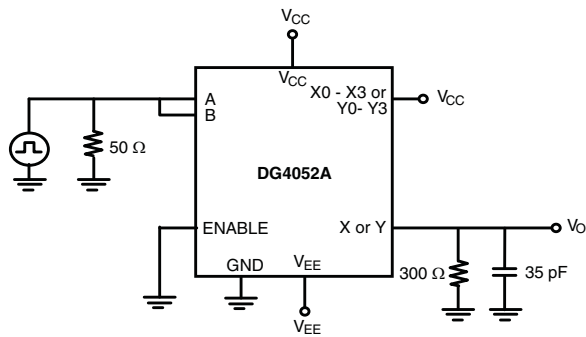
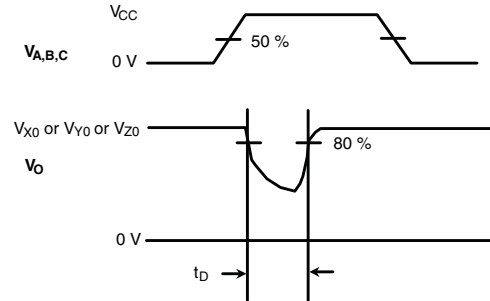
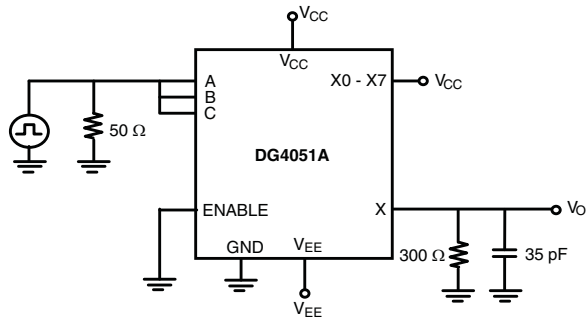


Figure 3. Break-Before-Make

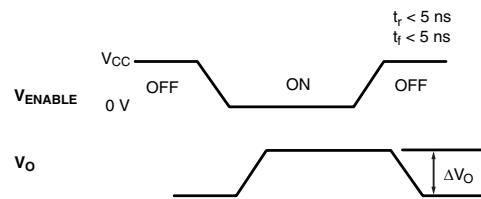
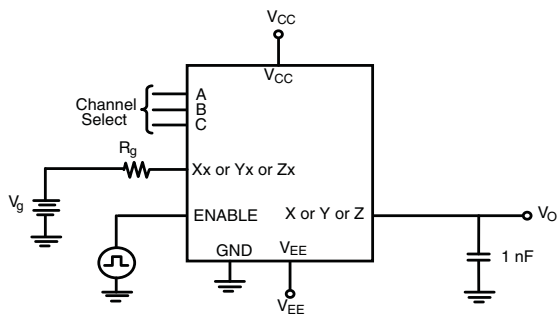
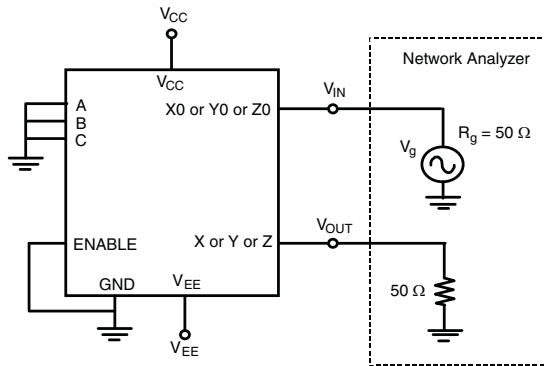


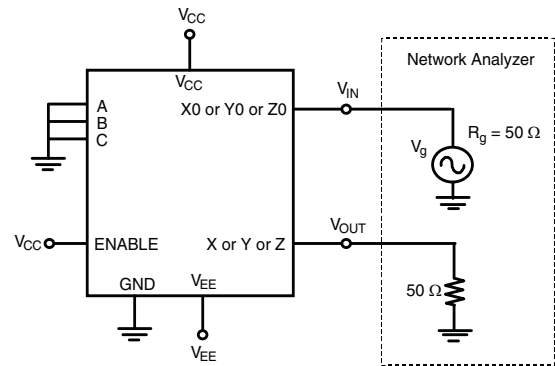
Figure 4. Charge Injection

TEST CIRCUITS



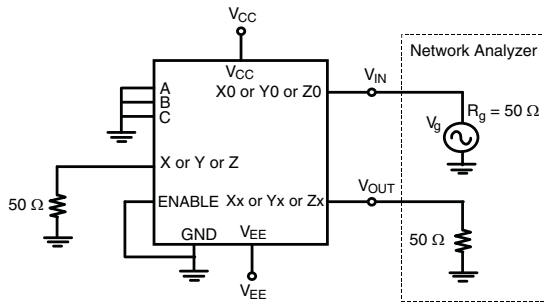
$$\text{Insertion Loss} = 20 \log \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

Figure 5. Insertion Loss



$$\text{Off Isolation} = 20 \log \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

Figure 6. Off Isolation



$$\text{Crosstalk} = 20 \log \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

Figure 7. Crosstalk

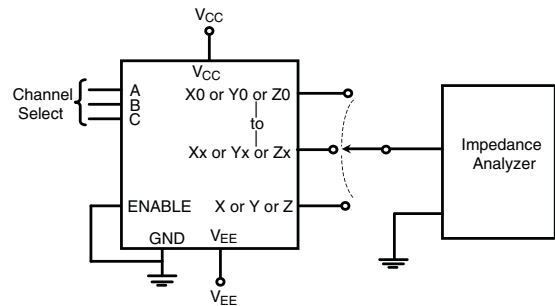
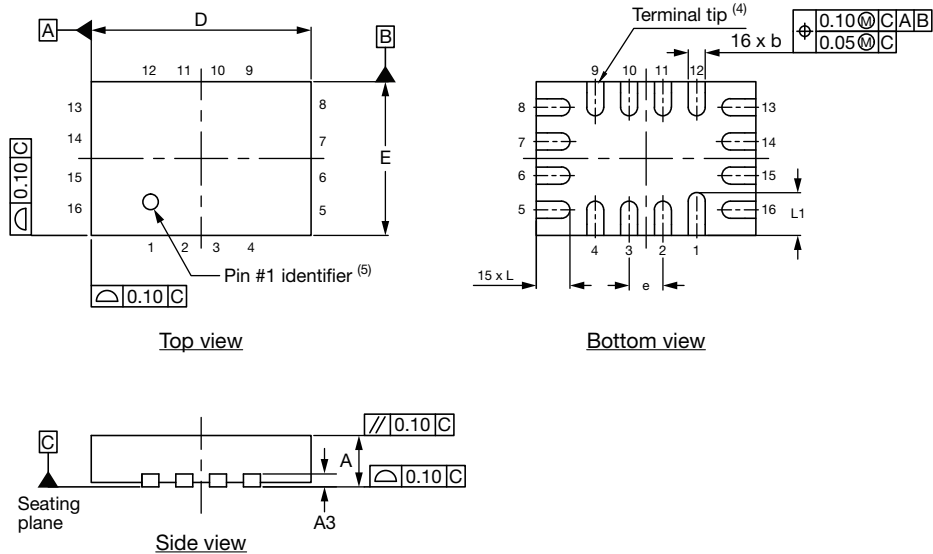


Figure 8. Source, Drain Capacitance

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?69828.

Thin miniQFN16 Case Outline



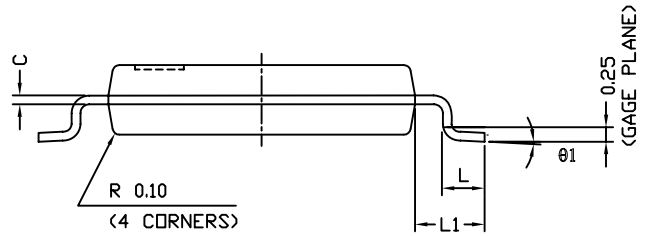
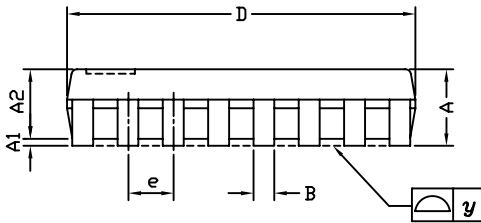
DIMENSIONS	MILLIMETERS ⁽¹⁾			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.50	0.55	0.60	0.020	0.022	0.024
A1	0	-	0.05	0	-	0.002
A3	0.15 ref.			0.006 ref.		
b	0.15	0.20	0.25	0.006	0.008	0.010
D	2.50	2.60	2.70	0.098	0.102	0.106
e	0.40 BSC			0.016 BSC		
E	1.70	1.80	1.90	0.067	0.071	0.075
L	0.35	0.40	0.45	0.014	0.016	0.018
L1	0.45	0.50	0.55	0.018	0.020	0.022
N ⁽³⁾	16			16		
Nd ⁽³⁾	4			4		
Ne ⁽³⁾	4			4		

Notes

- (1) Use millimeters as the primary measurement.
- (2) Dimensioning and tolerances conform to ASME Y14.5M. - 1994.
- (3) N is the number of terminals. Nd and Ne is the number of terminals in each D and E site respectively.
- (4) Dimensions b applies to plated terminal and is measured between 0.15 mm and 0.30 mm from terminal tip.
- (5) The pin 1 identifier must be existed on the top surface of the package by using identification mark or other feature of package body.
- (6) Package warpage max. 0.05 mm.

ECN: T16-0226-Rev. B, 09-May-16
DWG: 6023

TSSOP: 16-LEAD

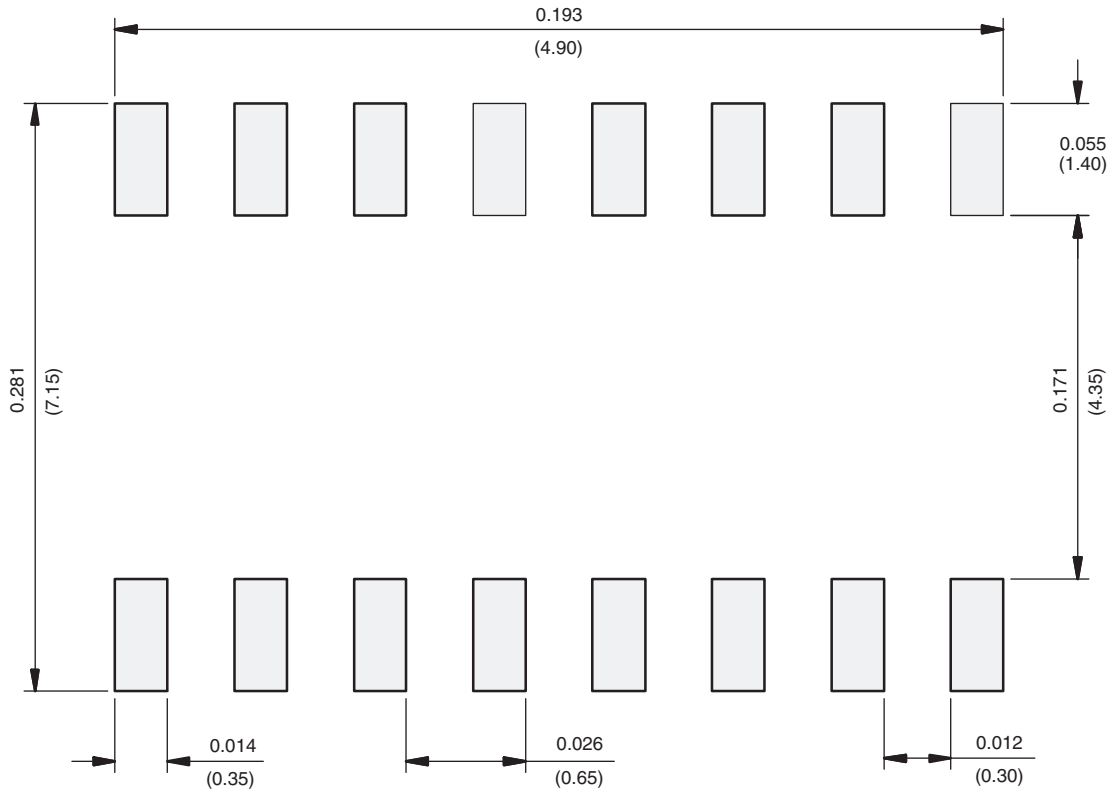


Symbols	DIMENSIONS IN MILLIMETERS		
	Min	Nom	Max
A	-	1.10	1.20
A1	0.05	0.10	0.15
A2	-	1.00	1.05
B	0.22	0.28	0.38
C	-	0.127	-
D	4.90	5.00	5.10
E	6.10	6.40	6.70
E1	4.30	4.40	4.50
e	-	0.65	-
L	0.50	0.60	0.70
L1	0.90	1.00	1.10
y	-	-	0.10
θ1	0°	3°	6°

ECN: S-61920-Rev. D, 23-Oct-06
DWG: 5624



RECOMMENDED MINIMUM PAD FOR TSSOP-16



Recommended Minimum Pads
Dimensions in inches (mm)

RECOMMENDED MINIMUM PADS FOR MINI QFN 16L



Mounting Footprint
Dimensions in mm (inch)



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